## Search Notes

| Application/Control No. | Applicant(s)/Patent Under<br>Reexamination |
|-------------------------|--|
| 10529968                | WEIS ET AL.                                |
| Examiner                | Art Unit                                   |
| STEVEN CERNOCH          | 3752                                       |

| SEARCHED |       |          |  |           |          |
|----------|-------|----------|--|-----------|----------|
| Class    |       | Subclass |  | Date      | Examiner |
| 239      | 428.5 |          |  | 2/12/2008 | SMC      |

| SEARCH NOTES |            |          |  |
|--------------|------------|----------|--|
| Search Notes | Date       | Examiner |  |
| EAST         | 2/12/2008  | SMC      |  |
| EAST         | 10/16/2008 | SMC      |  |
| EAST         | 6/17/2009  | SMC      |  |

|       | INTERFERENCE SEARCH |      |          |
|-------|---------------------|------|----------|
| Class | Subclass            | Date | Examiner |
|       |                     |      |          |

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